

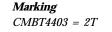
250 mW

150 ° C

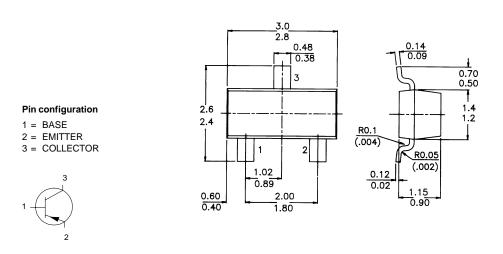
SOT-23 Formed SMD Package

SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor



PACKAGE OUTLINE DETAILS ALL DIMENSIONS IN mm



ABSOLUTE MAXIMUM RATINGS				
Collector-emitter voltage	$-V_{CEO}$	max.	40	V
Collector current (DC)	$-I_C$	max.	600	mA
DC current gain				
$I_C = 150 \text{ mA}; V_{CE} = 2 V$	h_{FE}	min.	100	
		max.	300	
Total power dissipation up to $T_{amb} = 25 \ ^{\circ}C$	P _{tot}	max	250	mW
RATINGS (at $T_A = 25^{\circ}C$ unless otherwise specified)				
Limiting values				
Collector-emitter voltage	$-V_{CEO}$	max.	40	V
Collector-base voltage	$-V_{CBO}$	max.	40	V
Emitter-base voltage	$-V_{EBO}$	max.	5	V
Collector current (DC)	$-I_C$	max.	600	mА

Collector current (DC) $-I_C$ max. Total power dissipation up to $T_{amb} = 25 \ ^{\circ}C$ P_{tot} max T_{stg} -55 to +150 °C Storage temperature range Junction temperature Τj max.

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THERMAL RESISTANCE	D		500	
From junction to ambient	R _{th j-a}	=	500	K/W
CHARACTERISTICS				
$T_{amb} = 25$ °C unless otherwise specified				
Collector-emitter breakdown voltage				
$-I_C = 1.0 \text{ mA}; I_B = 0$	$-V_{(BR)CEO}$	>	40	V
Collector-base breakdown voltage				. .
$-I_C = 100 \ \mu A; I_E = 0$	-V(BR)CBO	>	40	V
Emitter-base breakdown voltage	I <i>I</i>		~	T/
$-I_E = 100 \ \mu A; \ I_C = 0$	-V(BR)EBO	>	5	V
Base cut-off current $-V_{CE} = 35 V; -V_{EB} = 0.4 V$	-IBEX	_	0.1	μA
$-v_{CE} = 35 v_{c} - v_{EB} = 0.4 v$ Collector cut-off current	-IBEX	<	0.1	μА
$-V_{CE} = 35 V; -V_{EB} = 0.4 V$	-ICEX	<	01	μA
$C_E = 0000, V_{ED} = 0.100$	ICEA		0.1	<i>μ</i>
D.C. current gain				
$-I_C = 0.1 \text{ mA}; -V_{CE} = 1 \text{ V}$	hfe	>	30	
$-I_C = 1.0 \text{ mA}; -V_{CE} = 1 \text{ V}$	h_{FE}	>	60	
$-I_C = 10 mA; -V_{CE} = 1 V$	h _{FE}	>	100	
$-I_C = 150 \text{ mA}; -V_{CE} = 2 \text{ V}$	h_{FE}	10	00 to 300	
$-I_C = 500 \text{ mA; } -V_{CE} = 2 \text{ V}$	h_{FE}	>	20	
Saturation voltage				
$-I_C = 150 \text{ mA}; -I_B = 15 \text{ mA}$	-V _{CEsat}	<	0.4	V
	-V _{BEsat}	0.7	5 to 0.95	V
$L_{\alpha} = 500 \text{ m} A$; $L_{\alpha} = 50 \text{ m} A$	Van		0.75	I/
$-I_C = 500 \text{ mA}; -I_B = 50 \text{ mA}$	-VCEsat -VBEsat	< <	0.73 1.3	
	- v BEsat		1.5	v
Transition frequency				
$f = 100 \text{ MHz}; -I_C = 20 \text{ mA}; -V_{CE} = 10 \text{ V}$	f_T	>	200	MHz
Collector-base capacitance				
$I_E = 0; -V_{CB} = 10 V; f = 100 kHz$	C _{cb}	<	8.5	pF
Emitter-base capacitance	~			-
$I_C = 0; -V_{BE} = 0.5 V; f = 100 \text{ kHz}$	C _{eb}	<	35	pF
Input impedance at $f = 1$ kHz;	7		1.5	10
$-I_C = 1 mA; -V_{CE} = 10 V$	h _{ie}	min.	1.5	
		max.	15	kΩ
Voltage feed-back ratio at f = 1 kHz;				
$-I_C = 1 mA; -V_{CE} = 10 V$	h _{re}	<i>min.0.</i>	1×10^{-4}	
		max.	8 × 10 ⁻⁴	
Small-signal curent gain at f = 1 kHz				
$-I_C = 1 \ mA; \ -V_{CE} = 10 \ V$	h _{fe}	min.	60	
		max.	500	

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Output admittance at $f = 1$ kHz; $-I_C = 1$ mA; $-V_{CE} = 10$ V	h _{ce}	min. max.	1 μS 100 μS
Switching times (resistive load)			
Turn-on time			
$-I_C = 150 \text{ mA}; -I_{B1} = 15 \text{ mA};$			
$-V_{CC} = 30 V; -V_{EB} = 2 V$			
delay time	t _d	max.	15 ns
rise time	t _r	max.	20 ns
Turn-off time			
$-I_C = 150 \text{ mA}; -V_{CC} = 30 \text{ V};$			
$-I_{B1} = +I_{B2} = 15 \ mA$			
storage time	ts	max.	225 ns
fall time	t_f	max.	30 ns

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Data Sheet